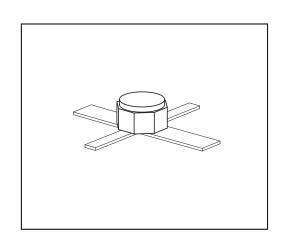


HiRel NPN Silicon RF Transistor

- HiRel Discrete and Microwave Semiconductor
- For High Gain Low Noise Amplifiers
- For Oscillators up to 10 GHz
- Noise Figure F = 1.1 dB at 1.8 GHz
 Outstanding G_{ms} = 21 dB at 1.8 GHz
- Hermetically sealed microwave package
- Transition Frequency f_T = 22 GHz
- SIEGET [®] 25 GHz f_T Line
 Infineon Technologies Grounded Emitter Transistor 25 GHz f_T- Line



esa Space Qualified

ESA/SCC Detail Spec. No.: 5611/008

Type Variant No. 02

ESD: Electrostatic discharge sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration					Package	
BFY420 (ql)	-	1=C	2=E	3=B	4=E	-	-	MICRO-X

(ql) Testing level: P: Professional testing

H: High Rel quality S: Space quality ES: ESA qualified

Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	$V_{\sf CEO}$	4.5	V	
Collector-base voltage	V_{CBO}	15		
Emitter-base voltage	V_{EBO}	1.5		
Collector current	I _C	35	mA	
Base current	I _B	3.0		
Total power dissipation	P _{tot}	160	mW	
$T_{\rm S} \le 129^{\circ}{\rm C}^{-1)2}$				
Junction temperature	T_{i}	175	°C	
Operating temperature range	T _{op}	-65 175	°C	
Storage temperature	$T_{ m stg}$	-65 175	°C	

¹At T_S = 129 °C. For T_S > 129 °C derating is required.

 $^{{}^{2}}T_{S}$ is measured on the collector lead at the soldering point to the pcb.



Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R_{thJS}	< 285	K/W

Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics	·				•
Collector-emitter cutoff current ²⁾	I _{CEX}	-	-	200	μΑ
$V_{CE} = 4.5 \text{ V}, I_{B} = 1.0 \mu\text{A}$					
Collector -base cutoff current	I _{CBO}	-	-	30	nA
$V_{CB} = 5 \text{ V}, I_{E} = 0$					
Emitter-base cutoff current	l _{EBO}	-	-	20	μΑ
$V_{EB} = 1.5 \text{ V}, I_{C} = 0$					
DC current gain	h _{FE}	50	90	150	-
$I_{\rm C} = 5 \text{ mA}, \ V_{\rm CE} = 1 \text{ V}$					

 $^{^{1}\}textit{T}_{\mbox{\scriptsize S}}$ is measured on the collector lead at the soldering point to the pcb.

 $^{^2}$ This test assures $V_{(BR)CE0} > 4.5V$



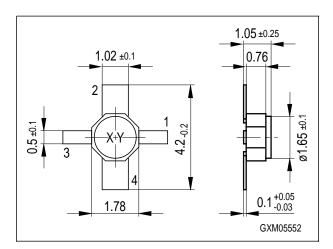
Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified Unit Symbol **Values Parameter** min. typ. max. AC Characteristics (verified by random sampling) 20 22 GHz Transition frequency fΤ $I_{\rm C} = 30 \text{ mA}, V_{\rm CE} = 3 \text{ V}, f = 2.0 \text{ GHz}$ Collector-base capacitance C_{cb} 0.14 0.9 pF $V_{CB} = 2 \text{ V}, V_{BE} = v_{be} = 0, f = 1 \text{ MHz}$ Collector emitter capacitance C_{ce} 0.46 0.85 $V_{CE} = 2 \text{ V}, V_{BE} = v_{be} = 0, f = 1 \text{ MHz}$ Emitter-base capacitance C_{eb} 0.67 3.0 $V_{\text{EB}} = 0.5 \text{ V}, \ V_{\text{CB}} = v_{\text{cb}} = 0, \ f = 1 \text{ MHz}$ Noise figure F 1.1 1.7 dΒ $I_C = 5 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_{Sopt}$ f = 1.8 GHz $G_{\rm ms}^{1)}$ Power gain 21 dB $I_{\rm C} = 20 \text{ mA}, \ V_{\rm CE} = 2 \text{ V}, \ f = 1.8 \text{ GHz},$ $Z_{S} = Z_{Sopt}$, $Z_{L} = Z_{Lopt}$ $|S_{21e}|^2$ Transducer gain 14 18 $I_{\rm C} = 20 \text{ mA}, \ V_{\rm CE} = 2 \text{ V}, \ Z_{\rm S} = Z_{\rm L} = 50 \ \Omega,$ f = 1.8 GHz P_{-1dB} 1dB Compression point dBm 12 $I_{\rm C} = 20 \text{ mA}, V_{\rm CE} = 2 \text{ V}, Z_{\rm S} = Z_{\rm Sopt}$

 $Z_L = Z_{Lopt}$, f = 1.8 GHz

 $^{^{1}}G_{ms} = |S_{21}/S_{12}|$



Micro-X Package





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